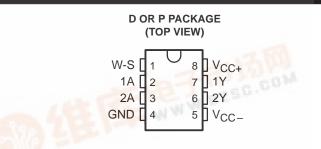
#### 查询UA9636ACDP供应商

## 捷多邦,专业PCB打样工厂,24小时加急出货 **uA9636AC** DUAL LINE DRIVER WITH ADJUSTABLE SLEW RATE

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- Meets or Exceeds the Requirements of ANSI Standards EIA/TIA-423-B and -232-E and ITU Recommendations V.10 and V.28
- **Output Slew Rate Control**
- **Output Short-Circuit-Current Limiting**
- Wide Supply Voltage Range
- 8-Pin Package
- Designed to Be Interchangeable With WWW.DZSC.COM National DS9636A

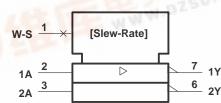


#### description

The uA9636AC is a dual, single-ended line driver designed to meet ANSI Standards EIA/TIA-423-B and EIA/TIA-232-E and ITU Recommendations V.10 and V.28. The slew rates of both amplifiers are controlled by a single external resistor, R(WS), connected between the wave-shape-control (W-S) terminal and GND. Output current limiting is provided. Inputs are compatible with TTL and CMOS and are diode protected against negative transients. This device operates from  $\pm 12$  V and is supplied in an 8-pin package.

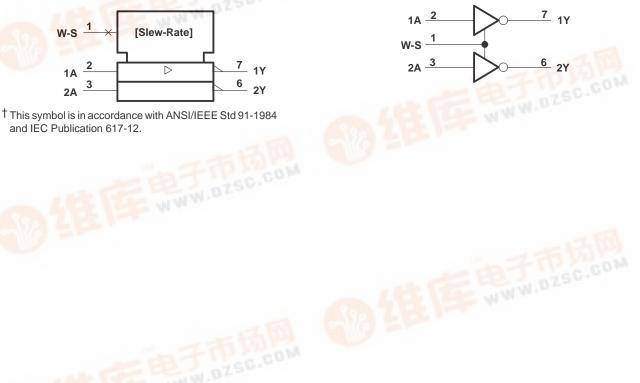
The uA9636AC is characterized for operation from 0°C to 70°C.

#### logic symbol<sup>†</sup>



and IEC Publication 617-12.

#### logic diagram



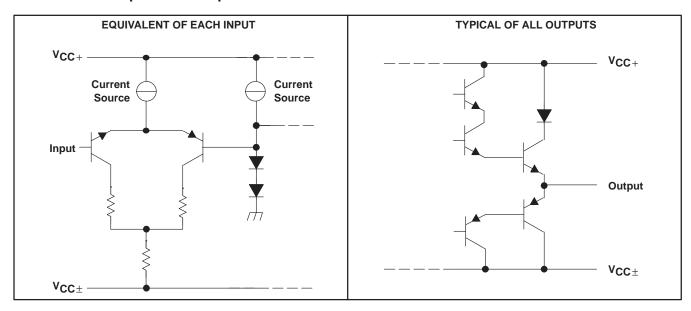


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SLLS110B – OCTOBER 1980 – REVISED MAY 1995

#### schematics of inputs and outputs



#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Positive supply voltage range, V <sub>CC+</sub> (see Note 1)	V <sub>CC</sub> _ to 15 V
Negative supply voltage range, V <sub>CC</sub>	0.5 V to –15 V
Output voltage, V <sub>O</sub>	±15 V
Output current, Io	±150 mA
Continuous total power dissipation	. See Dissipation Rating Table
Operating free-air temperature range, T <sub>A</sub>	0°C to 70°C
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTE 1: All voltage values are with respect to the network ground terminal.

OTE 1. All voltage values are with respect to the network ground terminal.

DISSIPATION RATING TABLE							
PACKAGE	T <sub>A</sub> ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T <sub>A</sub> = 25°C	T <sub>A</sub> = 70°C POWER RATING				
D	725 mW	5.8 mW/°C	464 mW				
Р	1000 mW	8.0 mW/°C	640 mW				

#### recommended operating conditions

	MIN	NOM	MAX	UNIT
Positive supply voltage, V <sub>CC+</sub>	10.8	12	13.2	V
Negative supply voltage, V <sub>CC</sub> _	-10.8	-12	-13.2	V
High-level input voltage, VIH	2			V
Low-level input voltage, VIL			0.8	V
Wave-shaping resistor, R(WS)	10		1000	kΩ
Operating free-air temperature, T <sub>A</sub>	0		70	°C



SLLS110B - OCTOBER 1980 - REVISED MAY 1995

# electrical characteristics over recommended ranges of free-air temperature, supply voltage, and wave-shaping resistance (unless otherwise noted)

PARAMETER		TEST	TEST CONDITIONS			MAX	UNIT
VIK	Input clamp voltage	lı = – 15 mA		-1.1	-1.5	V	
			R <sub>L</sub> = ∞	5	5.6	6	
VOH	High-level output voltage	$V_{I} = 0.8 V$	$R_L = 3 k\Omega$ to GND	5	5.6	6	V
			$R_L = 450 \Omega$ to GND	4	5.4	6	
V <sub>OL</sub>	Low-level output voltage		R <sub>L</sub> = ∞	-6‡	-5.7	-5	V
		V <sub>I</sub> = 2 V	$R_L = 3 k\Omega$ to GND	-6‡	-5.6	-5	
			$R_L = 450 \Omega$ to GND	-6‡	-5.4	-4	
	High-level input current	VI = 2.4 V	V <sub>1</sub> = 2.4 V			10	A
IН		V <sub>I</sub> = 5.5 V	V <sub>I</sub> = 5.5 V			100	μA
۱ <sub>IL</sub>	Low-level input current	VI = 0.4 V			-20	-80	μΑ
ю	Output current (power off)	$V_{CC\pm} = 0,$	$V_{O} = \pm 6 V$			±100	μΑ
IOS	Short-circut output current§	$V_{I} = 2 V$		15	25	150	A
		$V_{I} = 0$	-15	-40	-150	mA	
rO	Output resistance	RL = 450 Ω			25	50	Ω
ICC+	Positive supply current	$V_{CC} = \pm 12 \text{ V},$ $R_{(WS)} = 100 \text{ k}\Omega,$	VI = 0, Output open		13	18	mA
Icc-	Negative supply current	$V_{CC} = \pm 12 V,$ R(WS) = 100 k $\Omega$ ,	VI = 0, Output open		-13	-18	mA

<sup>†</sup> All typical values are at  $V_{CC} = \pm 12 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

<sup>‡</sup> The algebraic convention, in which the less-positive (more-negative) limit is designated as minimum, is used in this data sheet for logic voltage levels, e.g., when -5 V is the maximum, the minimum is a more-negative voltage.

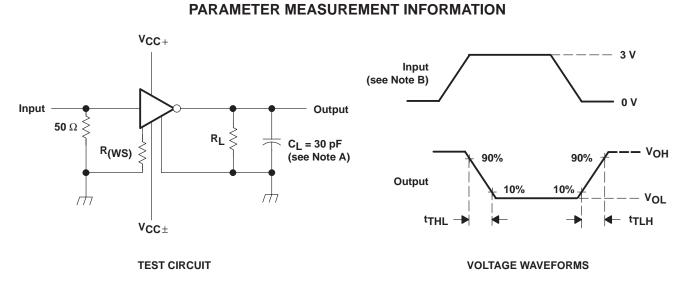
§ Not more than one output should be shorted to ground at a time.

#### switching characteristics, $V_{CC\pm} = \pm 12 \text{ V}$ , $T_A = 25^{\circ}C$ (see Figure 1)

	PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
t <sub>TLH</sub> Transition time, low- to high-level output		D: 450 kO	C: 20 pF	R <sub>(WS)</sub> = 10 kΩ	0.8	1.1	1.4	
	Transition time, low, to high lovel output			R(WS) = 100 kΩ	8	11	14	
	R <sub>L</sub> = 450 kΩ,	CL = 30 pF	R(WS) = 500 kΩ	40	55	70	μs	
				$R(WS) = 1 M\Omega$	80	110	140	
<sup>t</sup> THL	Transition time, high- to low-level output	R <sub>L</sub> = 450 kΩ,	C <sub>L</sub> = 30 pF	R(WS) = 10 kΩ	0.8	1.1	1.4	μs
				R(WS) = 100 kΩ	8	11	14	
				$R_{(WS)} = 500 \text{ k}\Omega$	40	55	70	
				$R_{(WS)} = 1 M\Omega$	80	110	140	

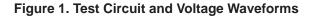


SLLS110B - OCTOBER 1980 - REVISED MAY 1995

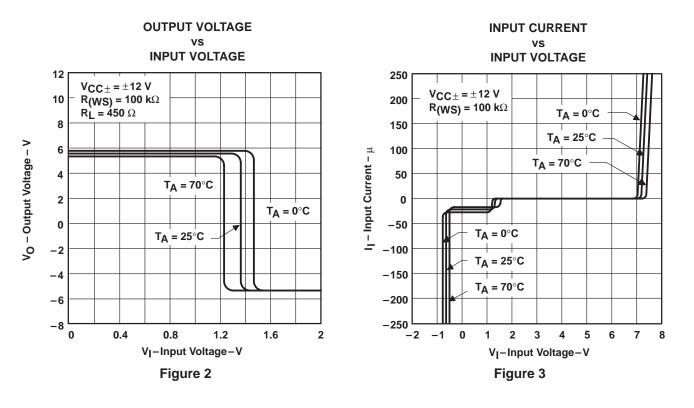


NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

B. The input pulse is supplied by a generator having the following characteristics:  $t_f \le 10$  ns,  $t_f \le 10$  ns,  $Z_O = 50 \Omega$ , PRR  $\le 1$  kHz, duty cycle = 50%.

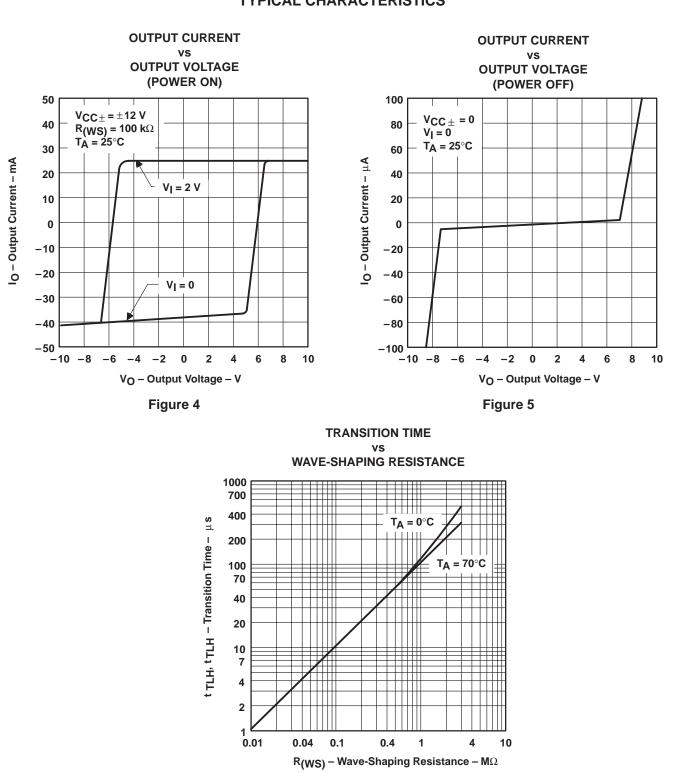


**TYPICAL CHARACTERISTICS** 





SLLS110B - OCTOBER 1980 - REVISED MAY 1995

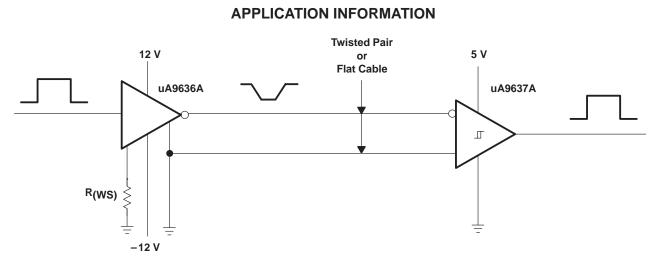


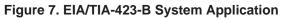
**TYPICAL CHARACTERISTICS** 

Figure 6



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